

2N5515 2N5516 2N5517 2N5518 2N5519
 2N5520 2N5521 2N5522 2N5523 2N5524

3

Siliconix

matched dual n-channel JFETs designed for . . .



Performance Curves NS See Section 5

BENEFITS

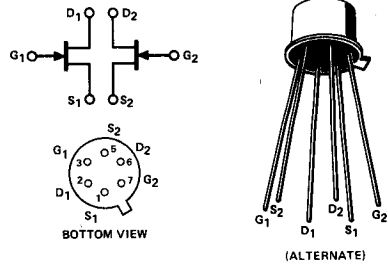
- Ultra-Low Noise
 $\bar{e}_n = 8 \text{ nV}/\sqrt{\text{Hz}}$ at 10 Hz (Typical)
 $\bar{e}_n = 2 \text{ nV}/\sqrt{\text{Hz}}$ at 1 kHz (Typical)
- Minimum System Error and Calibration
 5 mV Offset Maximum
 CMRR > 100 dB

■ Differential Amplifiers

*ABSOLUTE MAXIMUM RATINGS (25°C)

Gate-Drain or Gate-Source Voltage	-40 V
Gate Current	50 mA
Device Dissipation (Each Side), $T_A = 85^\circ\text{C}$ (Derate 2.0 mW/°C)	250 mW
Total Device Dissipation, $T_A = 85^\circ\text{C}$ (Derate 3.0 mW/°C)	375 mW
Storage Temperature Range	-65 to +150°C
Lead Temperature (1/16" from case for 30 seconds)	300°C

TO-71
See Section 7



*ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

Characteristic		Min	Max	Unit	Test Conditions										
S T A T I C	1 IGSS Gate Reverse Current		-250	pA	VGS = -30 V, VDS = 0										
	2 BVGSS Gate-Source Breakdown Voltage	-40	-250	nA	150°C										
	3 VGS(off) Gate-Source Cutoff Voltage	-0.7	-4	V	IG = -1 μA, VDS = 0										
	4 VGS Gate Source Voltage	-0.2	-3.8		VDS = 20 V, ID = 1 nA										
	5 IG Gate Operating Current		-100	pA	VDG = 20 V, ID = 200 μA										
D Y N A M I C	6 IDSS Saturation Drain Current (Note 1)	0.5	7.5	mA	125°C										
	7 9fs Common-Source Forward Transconductance (Note 1)	1000	4000		VDS = 20 V, VGS = 0										
	8 9fs Common-Source Forward Transconductance (Note 1)	500	1000	μmho	VDG = 20 V, ID = 200 μA										
	9 9os Common-Source Output Conductance		10		VDS = 20 V, VGS = 0										
	10 9os Common-Source Output Conductance		1		VDG = 20 V, ID = 200 μA										
	11 Ciss Common-Source Input Capacitance		25	pF	VDS = 20 V, VGS = 0										
	12 Crss Common-Source Reverse Transfer Capacitance		5	pF	f = 1 MHz										
	14 en Equivalent Short Circuit Input Noise Voltage	2N5515-19		30	nV	f = 10 Hz									
		2N5520-24		15	√Hz	f = 1 kHz									
		2N5515-24		10											
Characteristic		2N5515,20		2N5516,21		2N5517,22		2N5518,23		2N5519,24		Unit	Test Conditions		
M A T C H I N G	15 IG1-IG2 Differential Gate Current		10		10		10		10		10	nA	VDG = 20 V, ID = 200 μA	125°C	
	16 IDSS1 IDSS2 Saturation Drain Current Ratio (Notes 1 and 2)	0.95	1	0.95	1	0.95	1	0.95	1	0.90	1	-	VDS = 20 V, VGS = 0		
		17 VGS1-VGS2 Differential Gate-Source Voltage		5		5		10		15		15	mV		
	18 Δ VGS1-VGS2 Gate-Source Voltage Differential Drift (Note 3)		5		10		20		40		80		μV/°C	TA = 25°C	
		ΔT		5		10		20		40		80		μV/°C	TB = 125°C
19 9os1-9os2 Differential Output Conductance		0.1		0.1		0.1		0.1		0.1		μmho	TA = -55°C		
20 9fs1 9fs2 Transconductance Ratio (Notes 1 and 2)	0.97	1	0.97	1	0.95	1	0.95	1	0.90	1	-		TB = 25°C		
	21 CMRR Common Mode Rejection Ratio (Note 4)	100		100		90						dB	VDD = 10 to 20 V, ID = 200 μA		

*JEDEC registered data.

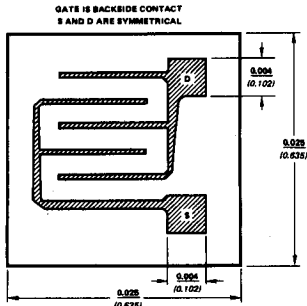
NOTES:

1. Pulse test required, pulsewidth = 300 μs, duty cycle ≤ 3%.
2. Assumes smaller value in numerator.

3. Measured at end points, TA and TB.

4. $CMRR = 20 \log_{10} \left(\frac{\Delta V_{DD}}{\Delta |V_{GS1} - V_{GS2}|} \right) \cdot \Delta V_{DD} = 10 \text{ V.}$

NS



ALL DIMENSIONS IN INCHES
(ALL DIMENSIONS IN MILLIMETERS)

n-channel JFET designed for . . .

- Low Noise Amplifiers
- Single and Differential Amplifiers

TYPE	PACKAGE
Dual	TO-71
Single	TO-72
Single	TO-92
Single	TO-92 Lead-form
Dual	Chip
Single	Chip



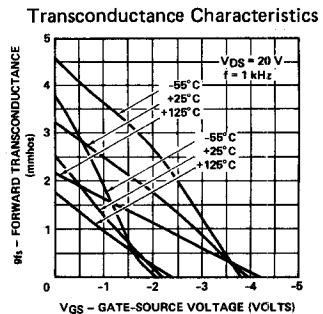
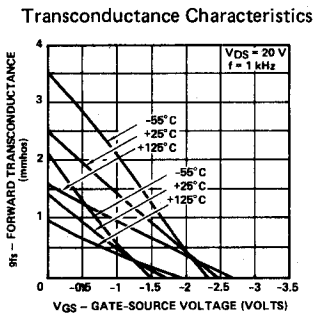
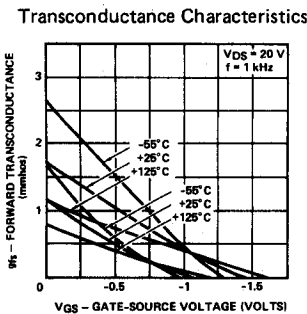
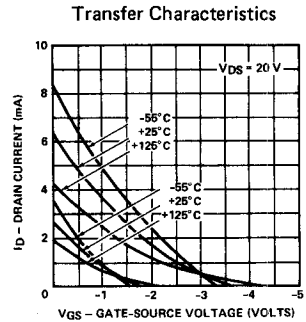
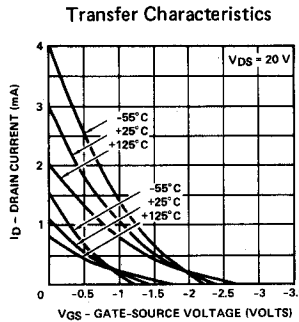
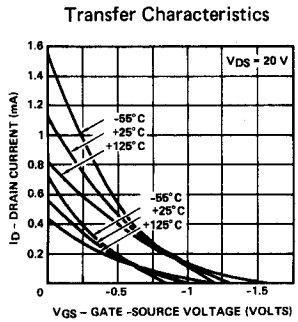
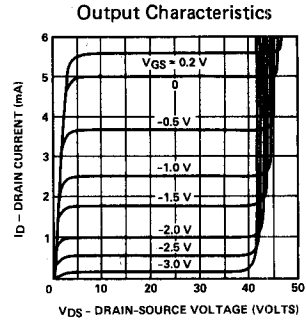
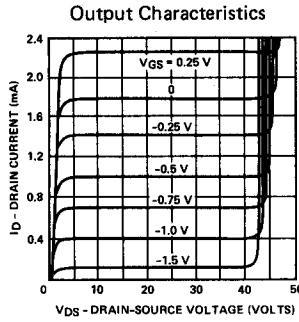
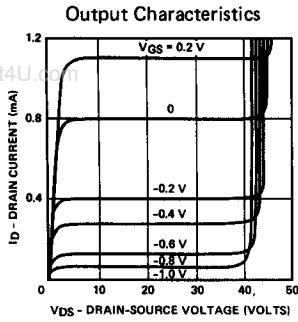
BENEFITS:

- Simplifies Amplifier Design
- Low Output Conductance
- Low 1/f Noise

PRINCIPAL DEVICES

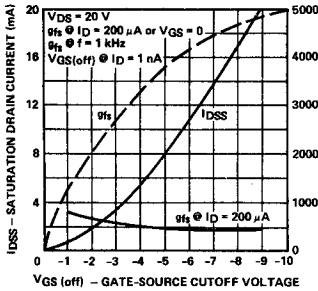
- 2N5515-24
- 2N4867-9, 2N4867A-69A
- J230-32
- J230-18 - 232-18
- 2N5518CHP-9CHP, 2N5523CHP-4CHP
- All of the above single devices

PERFORMANCE CURVES (25°C unless otherwise noted)

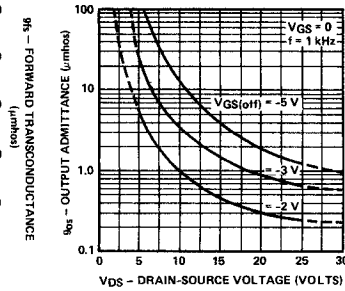


PERFORMANCE CURVES (Cont'd) (25°C unless otherwise noted)

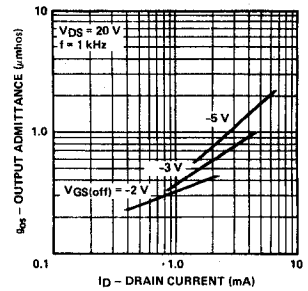
Saturation Drain Current and Forward Transconductance vs. Gate-Source Cutoff Voltage



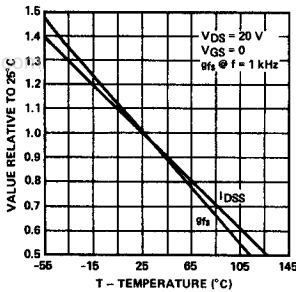
Common-Source Output Conductance vs Drain-Source Voltage



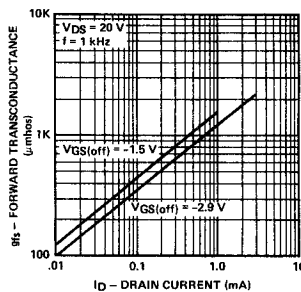
Common-Source Output Conductance vs Drain Current



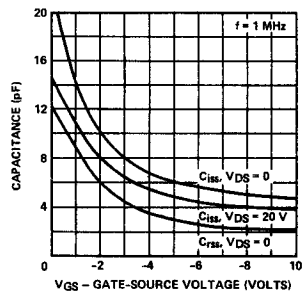
Drain Current & Transconductance vs Ambient Temperature



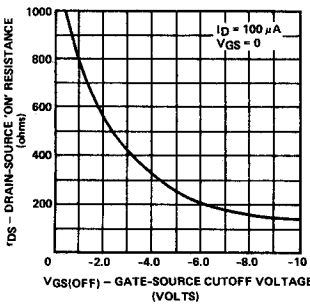
Common-Source Forward Transconductance vs Drain Current



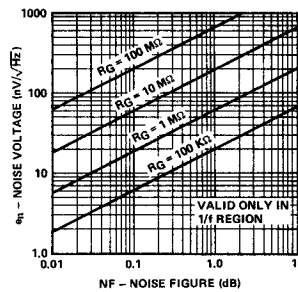
Common-Source Capacitance vs Gate-Source Voltage



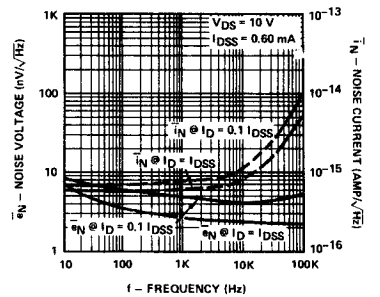
Static Drain-Source 'ON' Resistance vs Gate-Source Cutoff Voltage



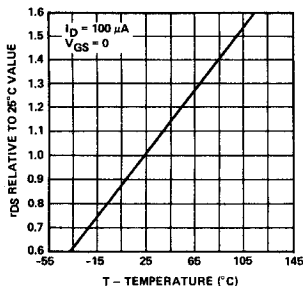
Approximate Noise Figure vs Input Noise Voltage



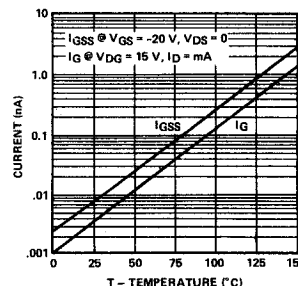
Equivalent Input Noise Voltage and Noise Current vs Frequency



Drain-Source 'ON' Resistance vs Ambient Temperature



Leakage Currents vs Ambient Temperature



Gate Operating Current vs Drain-Gate Voltage

